

PIP201-12M DC to DC converter powertrain Rev. 01 – 24 January 2002

Preliminary data

1. Description

The PIP201-12M is designed for use as the power output stage of a synchronous buck DC to DC converter. It contains a MOSFET control IC and two power MOSFET transistors. By combining the power MOSFETs and the driver circuit into a single component, stray inductances are virtually eliminated, resulting in higher switching frequency, lower switching losses and a compact, efficient design.

2. Features

- Optimized for conversion from 12 V
- Output current up to 20 A
- Operating frequency up to 1 MHz
- High efficiency
- Low-profile, surface mount package $(10 \times 10 \times 0.85 \text{ mm})$
- Compatible with any single or multi-phase PWM controller.

3. Applications

- Microprocessor voltage regulators
- Memory voltage regulators
- Low-voltage, high-current DC to DC converters.

4. Ordering information

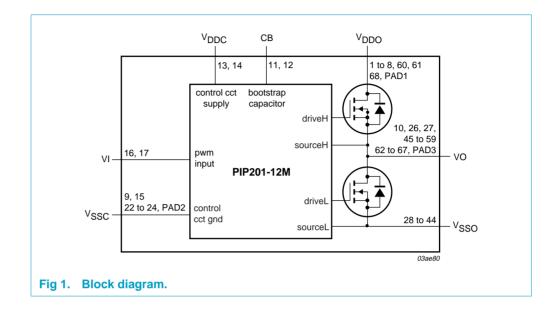
Table 1: Ordering information

Type number	Package				
	Name	Description	Version		
PIP201-12M	MLF68	plastic, heatsink very thin quad flat package; no leads; 68 terminals; body $10 \times 10 \times 0.85$ mm	SOT687		



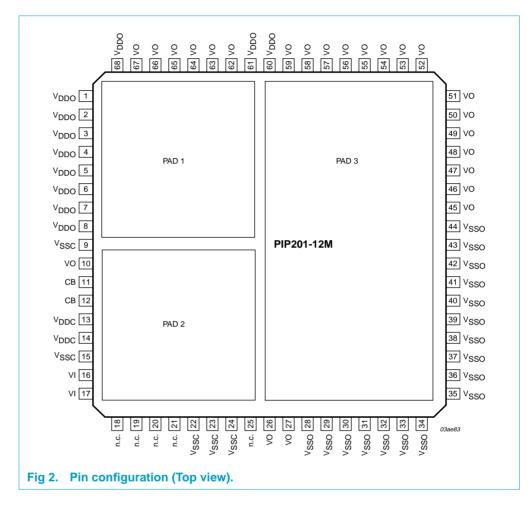
DC to DC converter powertrain

5. Block diagram



6. Pinning information

6.1 Pinning



6.2 Pin description

Pin description			
Pin		I/O	Description
1 to 8, 60, 61, 68	[1]	_	output stage supply voltage
9, 15, 22 to 24	[2]	_	control circuit supply ground
10, 26, 27, 45 to 59, 62 to 67	[3]	0	output
11, 12		I/O	bootstrap capacitor connection
13, 14		-	control circuit supply voltage
	Pin 1 to 8, 60, 61, 68 9, 15, 22 to 24 10, 26, 27, 45 to 59, 62 to 67 11, 12	Pin 1 to 8, 60, 61, [1] 68 [2] 9, 15, 22 to 24 [2] 10, 26, 27, [3] 45 to 59, [62 to 67] 11, 12 [1]	Pin I/O 1 to 8, 60, 61, [1] - 68 - - 9, 15, 22 to 24 [2] - 10, 26, 27, [3] O 45 to 59, 62 to 67 - 11, 12 I/O

DC to DC converter powertrain

Table 2:	Pin descriptionco	ntinued	
Symbol	Pin	I/O	Description
VI	16, 17	I	pulse width modulated input
n.c.	18 to 21, 25	-	not connected
V _{SSO}	28 to 44	_	output stage supply ground

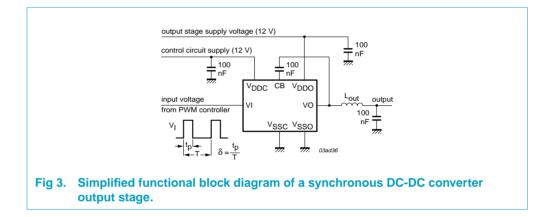
[1] All pins connected to PAD1

[2] All pins connected to PAD2

[3] All pins connected to PAD3.

7. Functional description

7.1 Application requirements

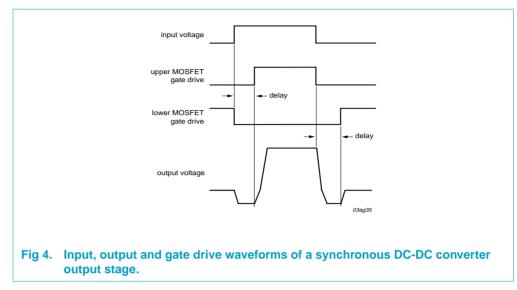


In order to understand the functions performed by the PIP201-12M, consider the requirements of a synchronous DC to DC converter output stage, driven from a PWM controller (Figure 3).

When the input voltage is HIGH, the upper MOSFET must be on and the lower MOSFET must be off. Current flows from the supply (V_{DDO}), through the upper MOSFET and the inductor (L_{out}), to the output.

When the input voltage is LOW and current is flowing in the inductor, the upper MOSFET must be off and the lower MOSFET must be on. Current flows from the power ground (V_{SSO}), through the lower MOSFET and the inductor (L_{out}), to the output.

Finally, when switching between states, both MOSFETs must not be on at the same time.



7.2 MOSFET driver function

The input, output and gate drive waveforms are shown in Figure 4. When the input voltage goes HIGH, the gate drive to the lower MOSFET immediately goes LOW. This causes the output current to flow through the source-drain diode of the lower MOSFET. This causes output voltage to fall from zero to approximately -0.7 V.

After a delay, if the input voltage is still HIGH, the gate drive to the upper MOSFET goes HIGH. This causes the output voltage to rise to the output stage supply voltage, $V_{\text{DDO.}}$

When the input voltage goes LOW, the gate drive to the upper MOSFET immediately goes LOW. The output voltage falls from V_{DDO} , until it is clamped by the source-drain diode of the synchronous FET at approximately -0.7 V.

After a delay, if the input voltage is still LOW, the gate drive to the lower MOSFET goes HIGH. The lower MOSFET turns on, and the output voltage rises from -0.7 V to zero.

7.3 Three-state function

If the input voltage remains between the upper and lower switching thresholds for longer than 144 ns (typical), both MOSFETs are turned off. This prevents the output capacitor bank from discharging through the lower MOSFET.

8. Limiting values

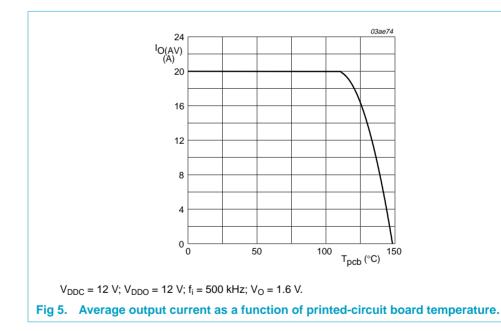
Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DDC}	control circuit supply voltage			-0.5	13	V
V _{DDO}	output stage supply voltage			-0.5	25	V
VI	input voltage			-0.5	5.25	V
Vo	output voltage			-0.5	V _{DDO} + 0.5	V
V _{CB}	bootstrap voltage			-0.5	V _O + 13	V
I _{O(AV)}	average output current	V_{DDC} = 12 V; $T_{pcb} \le$ 112 °C; Figure 5		-	20	А
I _{ORM}	repetitive peak output current	V_{DDC} = 12 V; $t_p \leq$ 10 μs	[1]	-	200	А
P _{tot}	total power dissipation	T _{pcb} = 25 °C	[2]	-	25	W
		$T_{pcb} = 90 \ ^{\circ}C$	[2]	-	12	W
T _{stg}	storage temperature			-55	+150	°C
Ti	operating junction temperature			-55	+150	°C

[1] Pulse width and repetition rate limited by maximum value of T_j.

[2] Assumes a thermal resistance from junction to printed-circuit board of 5 K/W.



9. Thermal characteristics

Table 4:	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-pcb)}	thermal resistance from junction to printed-circuit board		-	4	5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	device mounted on FR4 printed-circuit board; copper area around device 25×25 mm				
		no thermal vias	-	25	-	K/W
		with thermal vias	-	20	-	K/W

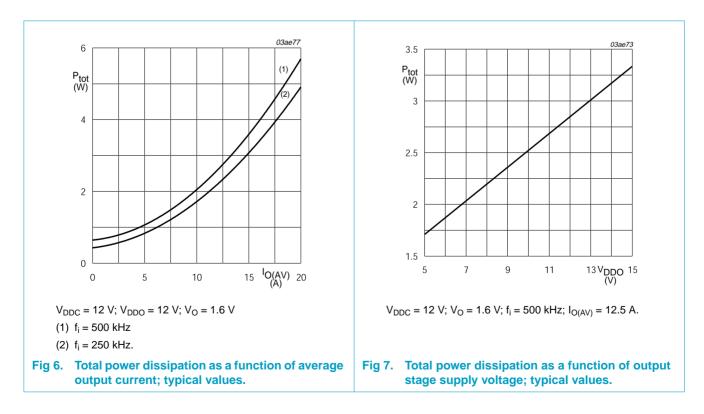
10. Characteristics

Table 5: Characteristics

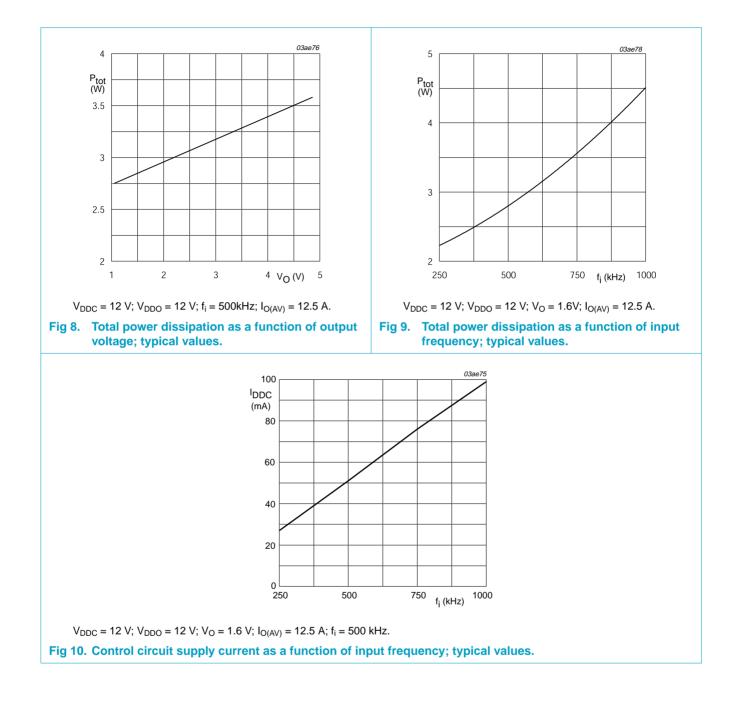
 V_{DDC} = 12 V; T_i = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static cha	racteristics						
V _{IH}	HIGH-level input voltage	$25 ^\circ\text{C} \leq \text{T}_j \leq 150 ^\circ\text{C}$	[1]	2.55	2.8	3.05	V
V _{IL}	LOW-level input voltage	$25 ^\circ\text{C} \leq \text{T}_j \leq 150 ^\circ\text{C}$	[1]	1.95	2.1	2.25	V
I _{LI}	input leakage current	$0 \ V \leq V_I \leq V_{DDC}$		-	10	100	nA
IDDC	control circuit supply current	f _i = 0 Hz		-	1.5	3	mA
		f _i = 500 kHz; Figure 10		-	45	60	mA
P _{tot}	total power dissipation	$\begin{split} V_{DDO} &= 12 \text{ V; } I_{O(AV)} = 12.5 \text{ A;} \\ f_i &= 500 \text{ kHz; } V_O = 1.6 \text{ V;} \\ T_{pcb} &= 90 ^{\circ}\text{C; } \text{Figure 6.} \end{split}$		-	2.7	-	W
Dynamic o	haracteristics						
t _{d(on)(IH-OH)}	turn-on delay time input HIGH to output HIGH	$V_{DDO} = 12 \text{ V}; \text{ I}_{O(AV)} = 12.5 \text{ A}$		-	77	85	ns
t _{d(off)(IL-OL)}	turn-off delay time input LOW to output LOW			-	30	45	ns
t _{o(r)}	output rise time			-	18	25	ns
t _{o(f)}	output fall time	_		-	12	20	ns
t _{d(3-state)}	3-state enable delay time	-		115	144	173	ns

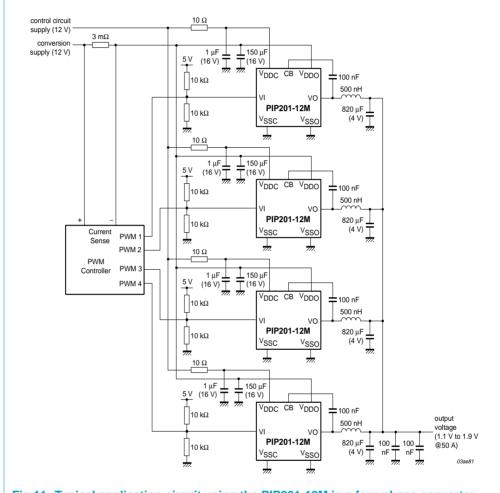
[1] If the input voltage remains between V_{IH} and V_{IL} (2.5 V typ) for longer than $t_{d(3-state)}$, then both MOSFETs are turned off.



DC to DC converter powertrain



11. Application information



11.1 Typical application

Fig 11. Typical application circuit using the PIP201-12M in a four-phase converter.

A typical four-phase buck converter is shown in Figure 11. This system uses four PIP201-12M devices to deliver a continuous output current of 50 A at an operating frequency of 500 kHz.

The dissipation in each PIP201-12M can be read from Figure 6. At 500 KHz and 12.5 A output current, the dissipation in each PIP201-12M is 2.7 W. In a typical computer motherboard application, the thermal resistance of each PIP201-12M from junction to ambient is 20 K/W. Assuming a maximum ambient temperature of 55 °C, the maximum junction temperature ($T_{i(max)}$) is given by:

$$T_{j(max)} = P_{tot} \times R_{th(j-a)} + T_{amb} = 2.7 \times 20 + 55 = 109^{\circ}C$$
(1)

The thermal resistance between the junction and the printed-circuit board is 5 K/W. Therefore, the maximum printed-circuit board temperature $(T_{pcb(max)})$ is given by:

 $T_{pcb(max)} = T_{j(max)} - P_{tot} \times R_{th(j-pcb)} = 127 - 2.7 \times 5 = 95.5^{\circ}C$ (2)

11.2 Advantages of an integrated driver

One problem in the design of low-voltage, high-current DC to DC converters using discrete components, is stray inductance between the various circuit elements.

Stray inductance in the gate drive circuit increases the switching times of the MOSFETs and causes high-frequency oscillation of the gate voltage.

Stray inductance in the high-current loop between V_{DDO} and V_{SSO} causes switching losses and electromagnetic interference. In discrete designs, high-frequency electric and magnetic fields radiate from PCB tracks and couple into adjacent circuits.

By integrating the power MOSFETs and their drive circuits into a single package, stray inductance is virtually eliminated, resulting in a compact, efficient design.

In discrete designs, the delays in the MOSFET drivers must be long enough to ensure no cross-conduction even when using the slowest MOSFETs. Use of an integrated driver allows the propagation delays in the MOSFET drivers to be precisely matched to the MOSFETs. This minimizes switching losses and eliminates cross-conduction whilst allowing the circuit to operate at a higher frequency.

11.3 Switching frequency

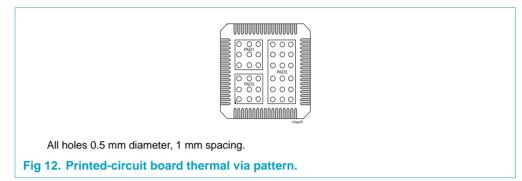
A high operating frequency reduces the size and number of capacitors needed to filter the output current, and also reduces the size of the output inductors. The disadvantage is higher dissipation due to switching and MOSFET driver losses. For example, doubling the operating frequency of the circuit in Figure 11 from 500 kHz to 1 MHz would increase the power dissipation in each PIP201-12M from 2.7 W to 4.5 W, at an output current of 12.5 A in each PIP201-12M.

The maximum switching frequency is limited by thermal considerations, the dissipation in the four PIP201-12M devices and the thermal resistance from junction to ambient.

11.4 Thermal design

The PIP201-12M has three pads on its underside. These are designated PAD1, PAD2 and PAD3 (Figure 2). PAD1 is connected to V_{DDO} , PAD2 is connected to V_{SSC} and PAD3 is connected to VO. In addition to providing low inductance electrical connections, these pads conduct heat away efficiently from the MOSFETs and control IC to the printed-circuit board. The thermal resistance from junction to printed-circuit board is approximately 5 K/W. In order to take full advantage of the low thermal resistance of this package, the printed-circuit board must be designed so that heat is conducted away efficiently from the package. This can be achieved by maximizing the area of copper around each pad, and by incorporating thermal vias to conduct the heat to inner and/or bottom layers of the printed-circuit board. An example of a thermal via pattern is shown in Figure 12. In a typical computer

motherboard application, with no forced air cooling, the use of thermal via holes typically reduces the thermal resistance from 25 K/W to 20 K/W. The additional use of a small fan can reduce this further to approximately 15 K/W.



The thermal resistance of a particular design can be measured by passing a known current through the source-drain diode of the lower MOSFET. The direction of current flow is into V_{SSO} and out of VO. The volt drop between V_{SSO} and VO is then measured and used to calculate the power dissipation in the PIP201-12M. The case temperature of the PIP201-12M can be measured using an infra-red thermometer. The thermal resistance can then be calculated using the following equation:

$$R_{th(j-pcb)} = \frac{T_{case} - T_{amb}}{I \times V_F}$$
(3)

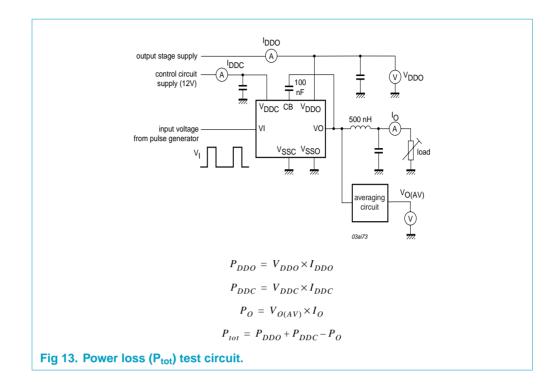
where T_{case} is the measured case temperature, T_{amb} is the ambient temperature, I is the MOSFET current and V_F is the volt drop between V_{SSO} and VO.

In a multi-phase design, the thermal resistance of each PIP201-12M should be measured with current flowing in all phases.

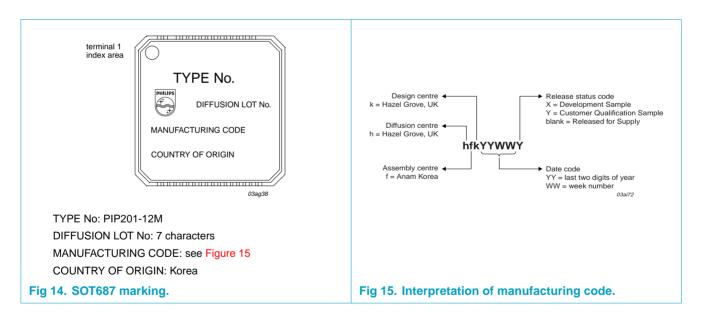
12. Test information

Figure 13 shows the test circuit used to measure power loss in the PIP201-12M. The output voltage is measured using an averaging circuit. This eliminates losses in the output inductor and the pcb tracks. The calculated power loss, using this method, includes the losses in the ESR of the input filter capacitors. This must be subtracted from the total loss to give the net loss in the PIP201-12M.

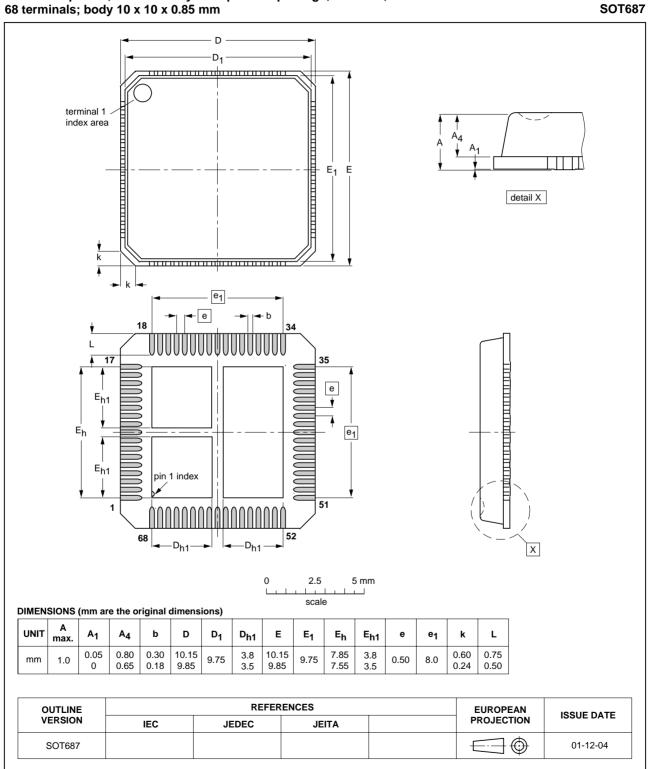
DC to DC converter powertrain



13. Marking



14. Package outline



HVQFN68: plastic, heatsink very thin quad flat package; no leads; 68 terminals; body 10 x 10 x 0.85 mm

Fig 16. SOT687; plastic, heatsink, very thin quad flat package; no leads; 68 terminals; body $10 \times 10 \times 0.85$ mm.

15. Soldering

15.1 Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *Data Handbook IC26; Integrated Circuit Packages* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

15.2 Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 220 °C for thick/large packages, and below 235 °C small/thin packages.

15.3 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

15.4 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 $^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 $^\circ\text{C}.$

15.5 Package related soldering information

Table 6:	Suitability of surface mount IC packages for wave and reflow soldering
	methods

Package	Soldering method		
	Wave	Reflow ^[1]	
BGA, HBGA, LFBGA, SQFP, TFBGA	not suitable	suitable	
HBCC, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, SMS	not suitable ^[2]	suitable	
PLCC ^[3] , SO, SOJ	suitable	suitable	
LQFP, QFP, TQFP	not recommended ^{[3][4]}	suitable	
SSOP, TSSOP, VSO	not recommended ^[5]	suitable	

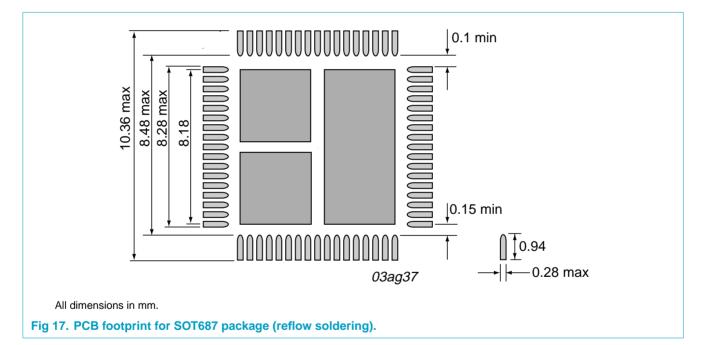
- [1] All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods.
- [2] These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- [3] If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- [4] Wave soldering is only suitable for LQFP, QFP and TQFP packages with a pitch (e) equal to or larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- [5] Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

16. Mounting

As shown in Figure 16, the terminals on the underside of the package are rectangular in shape with a rounded edge on the inside. Electrical connection between the package and the printed-circuit board is made by printing solder paste onto the PCB footprint followed by component placement and reflow soldering. The PCB footprint shown in Figure 17 is designed to form reliable solder joints.

In addition to the dimensions shown, a gap of at least 0.1 mm is recommended between each of the metal pads on the underside of the package, and also between the metal pads and the edge terminations. These clearances may need to be increased to prevent solder bridging. The use of solder resist between each pad is recommended.

Good surface flatness of the PCB footprint is desirable to ensure accuracy of placement after soldering. Printed-circuit boards that are finished with a roller tin process tend to leave small lumps of tin in the corners of each land. Levelling with a hot air knife improves flatness. Alternatively, an electro-less silver or silver immersion process produces completely flat PCB pads.



17. Revision history

Table 7:	Revision	history
		inotory

Rev	Date	CPCN	Description
01	20020124	-	Preliminary data (9397 750 09032); initial version.

18. Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definition
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A.

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

19. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

20. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no licence or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Contact information

For additional information, please visit http://www.semiconductors.philips.com. For sales office addresses, send e-mail to: sales.addresses@www.semiconductors.philips.com.

Fax: +31 40 27 24825

© Koninklijke Philips Electronics N.V. 2002. All rights reserved.

9397 750 09032

Contents

1	Description
2	Features
3	Applications
4	Ordering information
5	Block diagram 3
6	Pinning information 4
6.1	Pinning
6.2	Pin description 4
7	Functional description
7.1	Application requirements 5
7.2	MOSFET driver function 6
7.3	Three-state function 6
8	Limiting values
9	Thermal characteristics 8
10	Characteristics
11	Application information
11.1	Typical application 11
11.2	Advantages of an integrated driver 12
11.3	Switching frequency 12
11.4	Thermal design 12
12	Test information
13	Marking 14
14	Package outline
15	Soldering
15.1	Introduction to soldering surface mount
	packages 16
15.2	Reflow soldering 16
15.3	Wave soldering 16
15.4	Manual soldering 17
15.5	Package related soldering information 17
16	Mounting 18
17	Revision history
18	Data sheet status
19	Definitions
20	Disclaimers

© Koninklijke Philips Electronics N.V. 2002. Printed in The Netherlands

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.



Let's make things better.